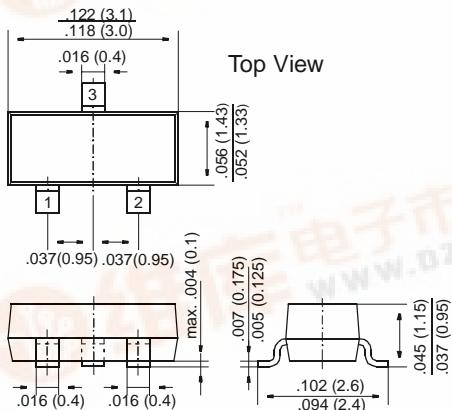


# 2N7002

## DMOS Transistors (N-Channel)

### SOT-23



Dimensions in inches and (millimeters)

Pin configuration  
1 = Gate, 2 = Source, 3 = Drain

### FEATURES

- ◆ High input impedance
- ◆ High-speed switching
- ◆ No minority carrier storage time
- ◆ CMOS logic compatible input
- ◆ No minority carrier storage time
- ◆ CMOS logic compatible input
- ◆ No thermal runaway
- ◆ No secondary breakdown



### MECHANICAL DATA

**Case:** SOT-23 Plastic Package

**Weight:** approx. 0.008 g

**Marking**

S72

### MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	60	V
Drain-Gate Voltage	V <sub>DGS</sub>	60	V
Gate-Source-Voltage (pulsed)	V <sub>GS</sub>	±20	V
Drain Current (continuous)	I <sub>D</sub>	250	mA
Power Dissipation at T <sub>C</sub> = 50 °C	P <sub>tot</sub>	0.310 <sup>1)</sup>	W
Junction Temperature	T <sub>j</sub>	150	°C
Storage Temperature Range	T <sub>s</sub>	-55 to +150	°C

<sup>1)</sup> Ceramic Substrate 0.7mm; 2.5 cm<sup>2</sup> area.

### Inverse Diode

	Symbol	Value	Unit
Max. Forward Current (continuous) at T <sub>amb</sub> = 25 °C	I <sub>F</sub>	0.3	A
Forward Voltage Drop (typ.) at V <sub>GS</sub> = 0, I <sub>D</sub> = 0.3 A, T <sub>j</sub> = 25 °C	V <sub>F</sub>	0.85	V

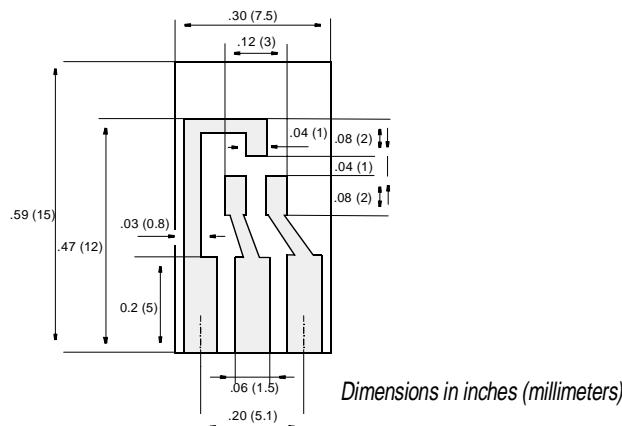
# 2N7002

## ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

	Symbol	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage at $I_D = 100 \mu A$ , $V_{GS} = 0$	$V_{(BR)DSS}$	60	90	—	V
Gate Threshold Voltage at $V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$	$V_{GS(th)}$	—	2	2.5	V
Gate-Body Leakage Current at $V_{GS} = 15 \text{ V}$ , $V_{DS} = 0$	$I_{GSS}$	—	—	10	nA
Drain Cutoff Current at $V_{DS} = 25 \text{ V}$ , $V_{GS} = 0$	$I_{DSS}$	—	—	0.5	$\mu A$
Drain-Source ON Resistance at $V_{GS} = 10 \text{ V}$ , $I_D = 500 \text{ mA}$	$r_{DS(ON)}$	—	5	7.5	$\Omega$
Thermal Resistance Junction to Substrate Backside	$R_{thSB}$	—	—	320 <sup>1)</sup>	K/W
Thermal Resistance Junction to Ambient Air	$R_{thJA}$	—	—	450 <sup>1)</sup>	K/W
Forward Transconductance at $V_{DS} = 10 \text{ V}$ , $I_D = 200 \text{ mA}$ , $f = 1 \text{ MHz}$	$g_m$	—	200	—	mS
Input Capacitance at $V_{DS} = 10 \text{ V}$ , $V_{GS} = 0$ , $f = 1 \text{ MHz}$	$C_{iss}$	—	60	—	pF
Switching Times at $V_{GS} = 10 \text{ V}$ , $V_{DS} = 10 \text{ V}$ , $R_D = 100 \Omega$ Turn-On Time Turn-Off Time	$t_{on}$ $t_{off}$	— —	5 25	— —	ns ns

<sup>1)</sup> Device on fiberglass substrate, see layout

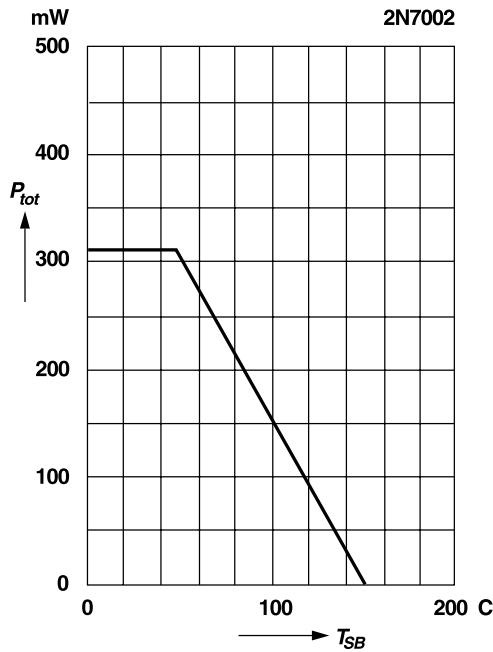


### Layout for $R_{thJA}$ test

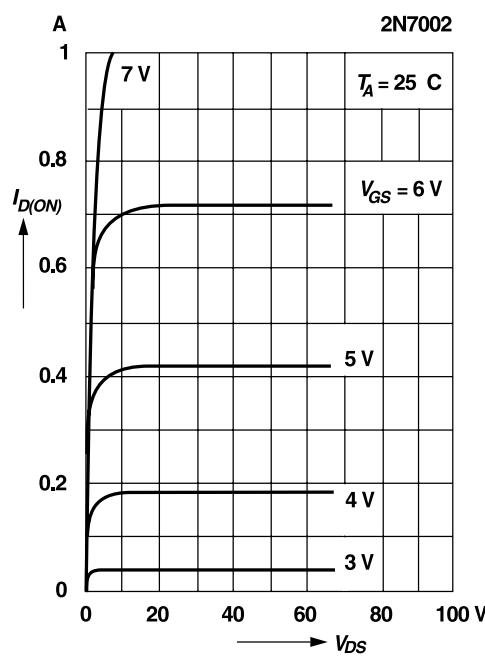
Thickness: Fiberglass 0.059 in (1.5 mm)  
Copper leads 0.012 in (0.3 mm)

## RATINGS AND CHARACTERISTIC CURVES 2N7002

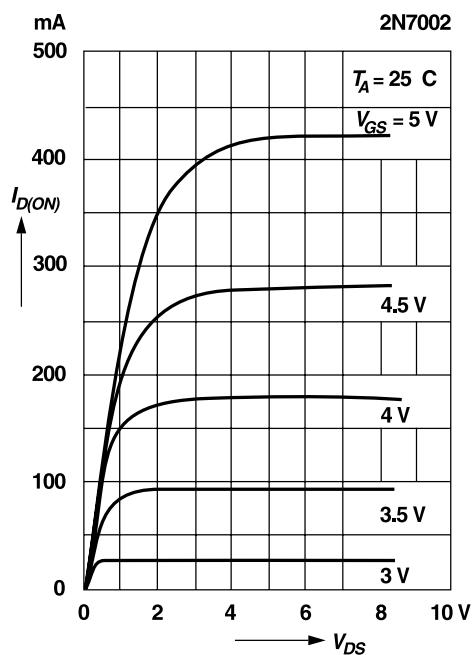
**Admissible power dissipation  
versus temperature of substrate backside**  
Device on fiberglass substrate, see layout



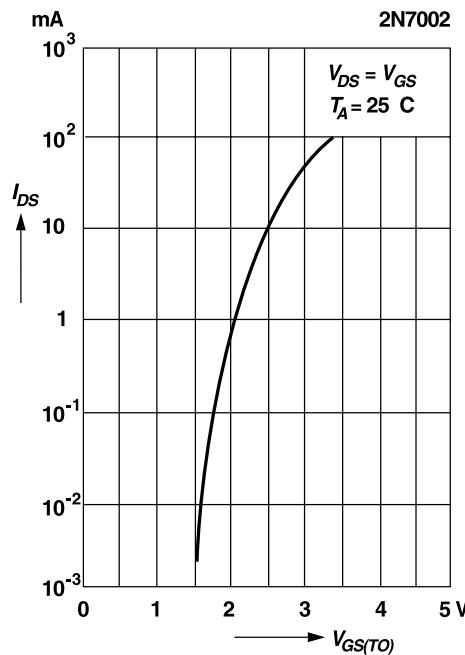
**Output characteristics**  
Pulse test width 80 ms; pulse duty factor 1%.



**Saturation characteristics**  
Pulse test width 80 ms; pulse duty factor 1%.



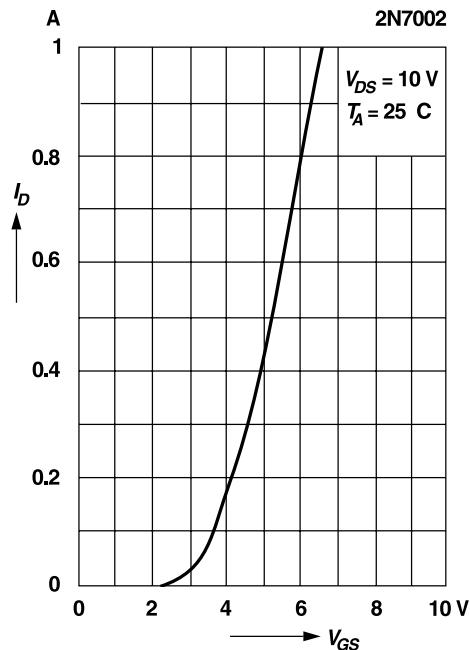
**Drain-source current  
versus gate threshold voltage**



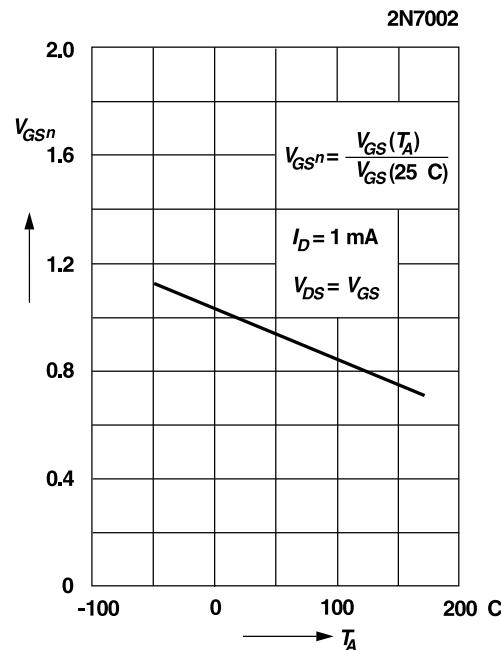
## RATINGS AND CHARACTERISTIC CURVES 2N7002

**Drain current  
versus gate-source voltage**

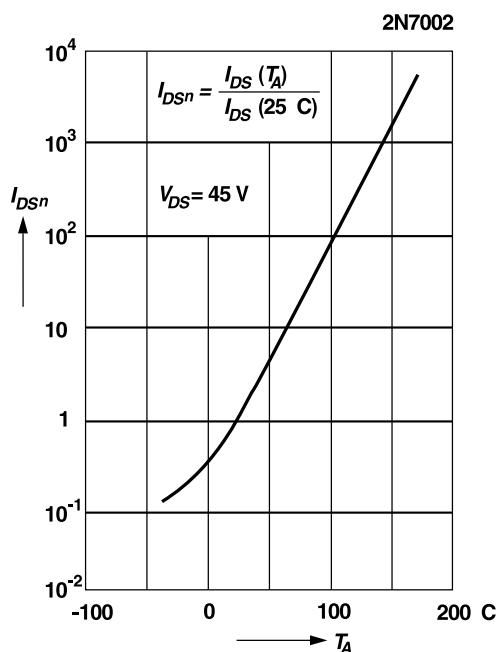
Pulse test width 80 ms; pulse duty factor 1%.



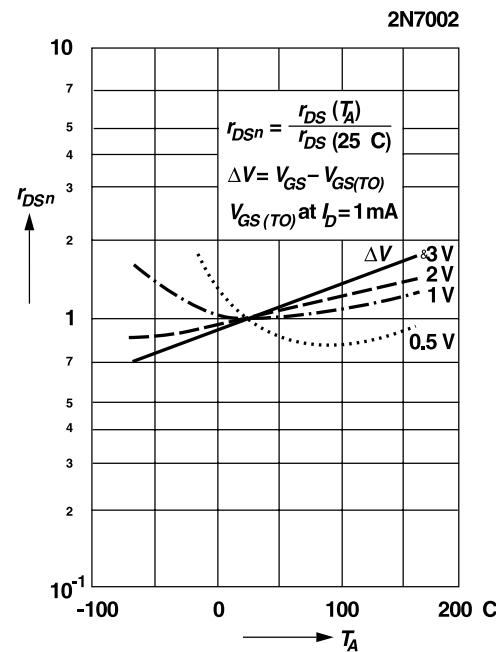
**Normalized gate-source voltage  
versus temperature**



**Normalized drain-source current  
versus temperature**

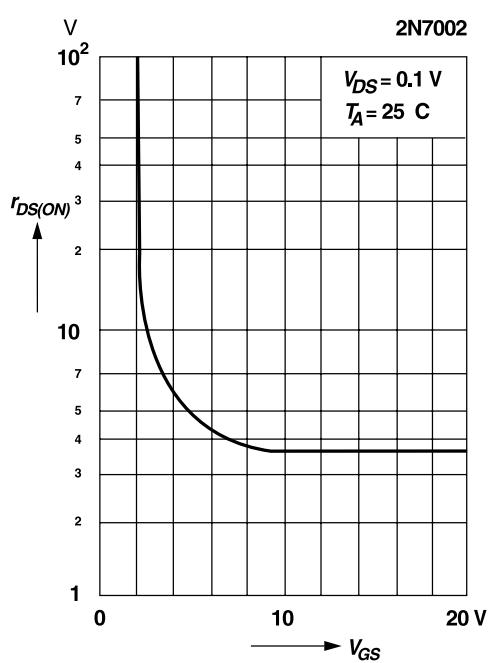


**Normalized drain-source resistance  
versus temperature**



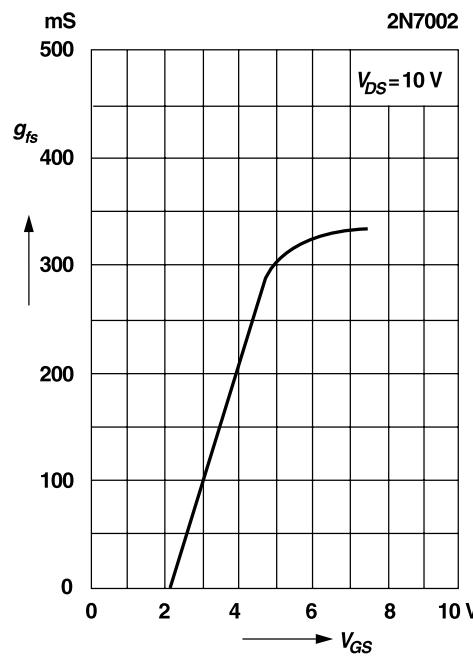
## RATINGS AND CHARACTERISTIC CURVES 2N7002

Drain-source resistance  
versus gate-source voltage



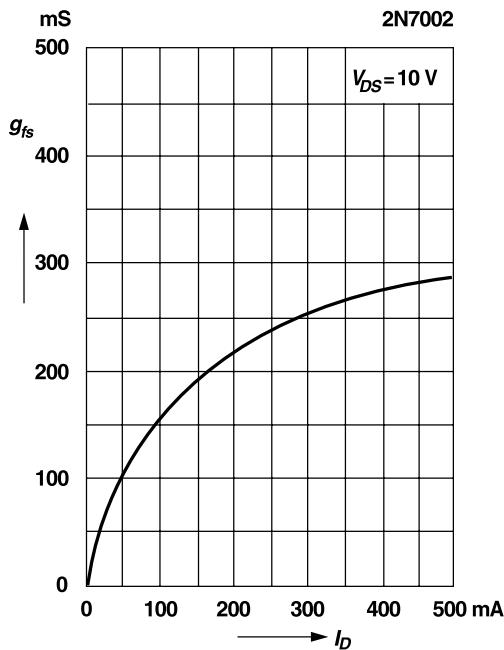
Transconductance  
versus gate-source voltage

Pulse test width 80 ms; pulse duty factor 1%



Transconductance  
versus drain current

Pulse test width 80 ms; pulse duty factor 1%



Capacitance  
versus drain-source voltage

